

**Notice of References Cited**

Application/Control No.

10/644,162

Applicant(s)/Patent Under  
Reexamination  
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Examiner

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Art Unit

2129

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**U.S. PATENT DOCUMENTS**

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Name	Classification
	A	US-			
	B	US-			
	C	US-			
	D	US-			
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**FOREIGN PATENT DOCUMENTS**

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**NON-PATENT DOCUMENTS**

*		Include as applicable: Author, Title Date, Publisher, Edition or Volume, Pertinent Pages)
	U	Christoph H. Loch • Christian Terwiesch • Stefan Thomke "parallel and sequential testing of design alternatives" management science, vol 45, no. 5, May 2001
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\*A copy of this reference is not being furnished with this Office action. (See MPEP § 707.05(a).)  
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